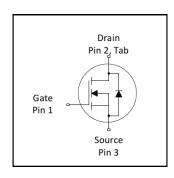
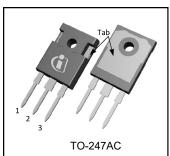
IRFP4137PbF



V _{DSS}	300V
R _{DS(on)} typ.	56mΩ
max.	69m Ω
I _D	38A





Applications

- High Efficiency Synchronous Rectification in SMPS
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

Benefits

- Improved Gate, Avalanche and Dynamic dv/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free, RoHS Compliant

Base Part Number	Packago Typo	Standard Pack		Orderable Part Number
base Part Number	Package Type	Form	Quantity	Orderable Part Number
IRFP4137PbF	TO-247	Tube	25	IRFP4137PbF

Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	38	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	27	Α
I_{DM}	Pulsed Drain Current ①	152	
P _D @T _C = 25°C	Maximum Power Dissipation	341	W
	Linear Derating Factor	2.3	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery ③	8.9	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		_ °C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10lbf.in (1.1N.m)	

Avalanche Characteristics

	E _{AS} (Thermally limited)	Single Pulse Avalanche Energy ②	541	mJ
--	-------------------------------------	---------------------------------	-----	----

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case ®		0.44	
$R_{\theta CS}$	Case-to-Sink, Flat Greased Surface	0.24		°C/W
$R_{\theta JA}$	Junction-to-Ambient ⑦⑨		40	

1 **Rev. 2.1**, 2024-12-05



Static @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
	Drain-to-Source Breakdown Voltage	300			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.24		V/°C	Reference to 25°C, I _D = 3.5mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		56	69	mΩ	V _{GS} = 10V, I _D = 24A ④
$V_{GS(th)}$	Gate Threshold Voltage	3.0		5.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
I _{DSS}	Drain-to-Source Leakage Current			20		$V_{DS} = 300V, V_{GS} = 0V$
				250	μA	$V_{DS} = 300V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I_{GSS}	Gate-to-Source Forward Leakage			100	nΛ	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V
R_G	Gate Resistance		1.3		Ω	

Dynamic @ $T_J = 25^{\circ}C$ (unless otherwise specfied)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	45			S	$V_{DS} = 50V, I_{D} = 24A$
Q_g	Total Gate Charge		83	125		I _D = 24A
Q_{gs}	Gate-to-Source Charge		28	42	nC	V _{DS} =150V
Q_{gd}	Gate-to-Drain ("Miller") Charge		26	39		V _{GS} = 10V ⑤
t _{d(on)}	Turn-On Delay Time		18			V _{DD} = 195V
	Rise Time		23		l	I _D = 24A
$t_{d(off)}$	Turn-Off Delay Time		34		ns	$R_G = 2.2\Omega$
t _f	Fall Time		20			V _{GS} = 10V
C _{iss}	Input Capacitance		5168			$V_{GS} = 0V$
C _{oss}	Output Capacitance		300			$V_{DS} = 50V$
C_{rss}	Reverse Transfer Capacitance		77		nE	f = 1.0 MHz,
C _{oss} eff. (ER)	Effective Output Capacitance (Energy Related)		196			V _{GS} = 0V, V _{DS} = 0V to 240V,⑥ See Fig.11
C _{oss} eff. (TR)	Effective Output Capacitance (Time Related)		265			V _{GS} = 0V, V _{DS} = 0V to 240V 10V ⑤

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Condi	tions
Is	Continuous Source Current			40		MOSFET symbol	P
	(Body Diode) ①			40	_	showing the	
I _{SM}	Pulsed Source Current			100	Α	integral reverse	
	(Body Diode) ①			160		p-n junction diode.	s
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$, $I_S = 24A$,	V _{GS} = 0V ④
t _{rr}	Reverse Recovery Time		302		ns	T _J = 25°C	
			379			T _J = 125°C	- V _R = 255V,
Q _{rr}	Reverse Recovery Charge		1739		nC	T _J = 25°C	$I_F = 24A$
			2497		1	T _J = 125°C	di/dt = 100A/µs ④
I _{RRM}	Reverse Recovery Current		13		Α	T _J = 25°C	-

Notes:

- ① Repetitive rating; pulse width limited by max. Junction temperature.

- ④ Pulse width ≤ 400 μ s; duty cycle ≤ 2%.
- © Coss eff. (TR) is a fixed capacitance that gives the same charging time as Coss while V_{DS} is rising from 0 to 80% V_{DSS}.
- ⑥ Coss eff. (ER) is a fixed capacitance that gives the same energy as Coss while V_{DS} is rising from 0 to 80% V_{DSS}.
- ©When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-0994
- $\ensuremath{\$}\ R_{\theta}$ is measured at T_J approximately 90°C.



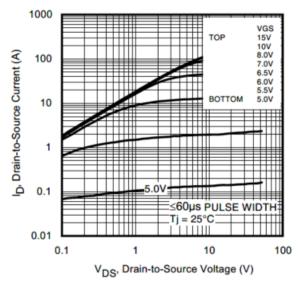


Fig 1. Typical Output Characteristics

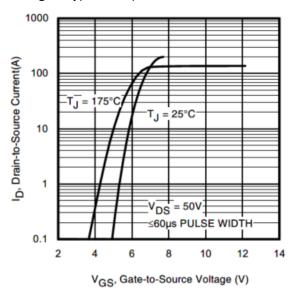


Fig 3. Typical Transfer Characteristics

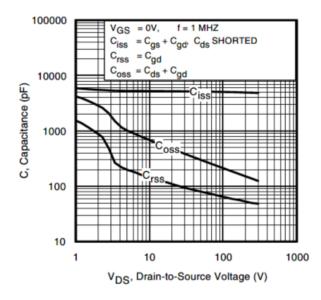


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

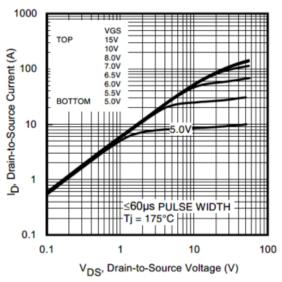


Fig 2. Typical Output Characteristics

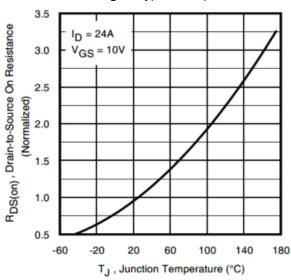


Fig 4. Normalized On-Resistance vs. Temperature

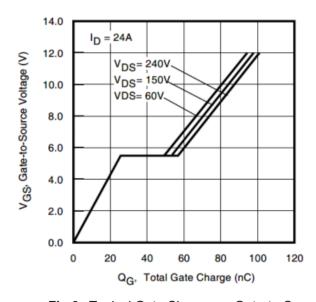


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

3



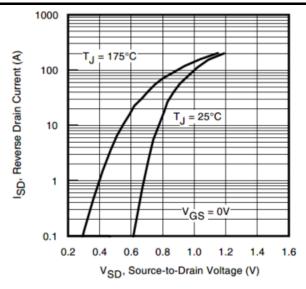


Fig 7. Typical Source-to-Drain Diode Forward Voltage

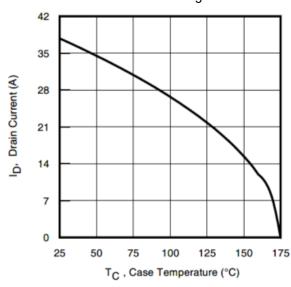


Fig 9. Maximum Drain Current vs. Case Temperature

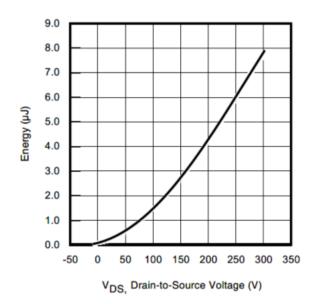


Fig 11. Typical Coss Stored Energy

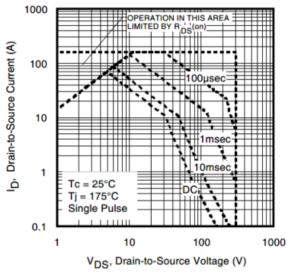


Fig 8. Maximum Safe Operating Area

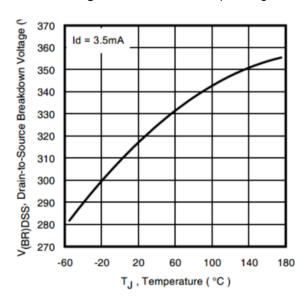


Fig 10. Drain-to-Source Breakdown Voltage

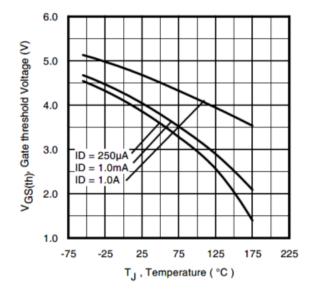


Fig 12. Maximum Avalanche Energy vs. Drain Current



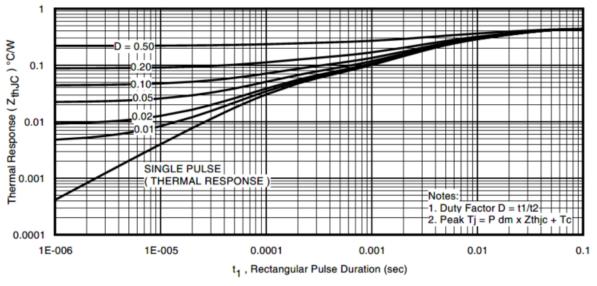
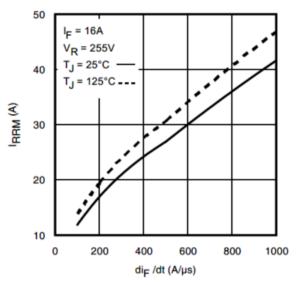


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

60

50

40



IRRM (A) 30 20 10 600 0 200 400 di_F /dt (A/µs)

I_E = 24A V_R = 255V

 $T_{J} = 125^{\circ}C -$

Fig 14. Typical Recovery Current vs. dif/dt

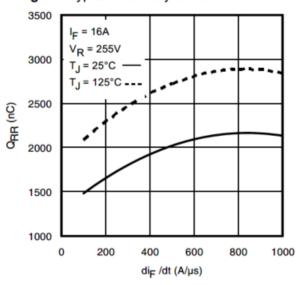


Fig 15. Typical Recovery Current vs. dif/dt

1000

800

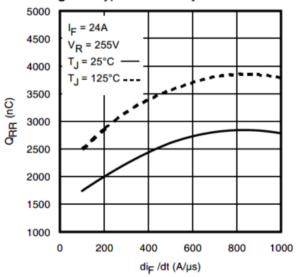


Fig 16. Typical Stored Charge vs. dif/dt

Fig 17. Typical Stored Charge vs. dif/dt



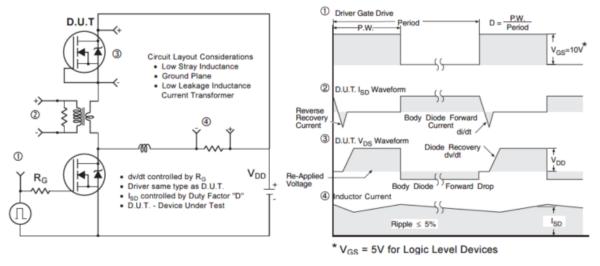


Fig 18. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

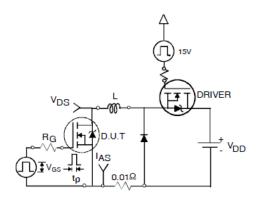


Fig 19a. Unclamped Inductive Test Circuit

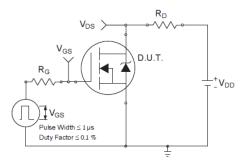


Fig 20a. Switching Time Test Circuit

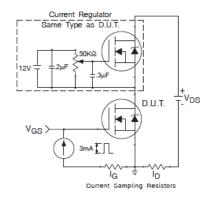


Fig 21a. Gate Charge Test Circuit

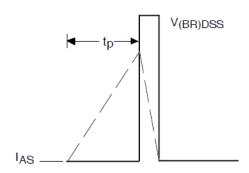


Fig 19b. Unclamped Inductive Waveforms

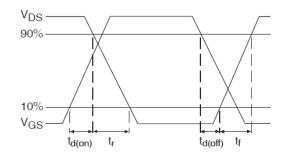


Fig 20b. Switching Time Waveforms

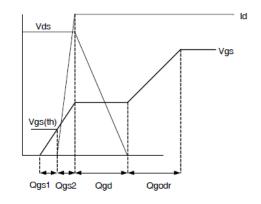
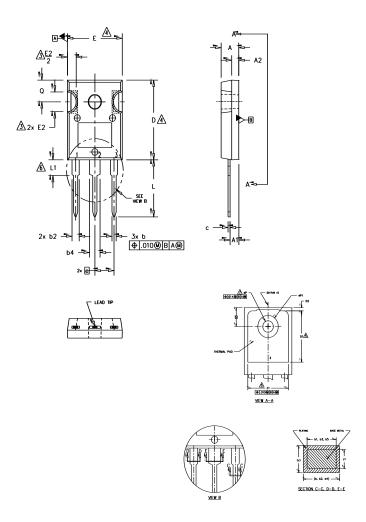


Fig 21b. Gate Charge Waveform



TO-247AC Package Outline (Dimensions are shown in millimeters (inches))



NOTES:

DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.

DIMENSIONS ARE SHOWN IN INCHES.

CONTOUR OF SLOT OPTIONAL.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED .005" (0.127)
PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.

LEAD FINISH UNCONTROLLED IN L1.

OP TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5 * TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.

OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC .

	DIMENSIONS				
SYMBOL	INC	HES	MILLIMETERS		1
	MIN.	MAX.	MIN.	MAX.	NOTES
Α	.183	.209	4.65	5.31	
A1	.087	.102	2.21	2.59	
A2	.059	.098	1.50	2.49	
b	.039	.055	0.99	1.40	
b1	.039	.053	0.99	1.35	
b2	.065	.094	1.65	2.39	
b3	.065	.092	1.65	2.34	
b4	.102	.135	2.59	3.43	
b5	.102	.133	2.59	3.38	
С	.015	.035	0.38	0.89	
c1	.015	.033	0.38	0.84	
D	.776	.815	19.71	20.70	4
D1	.515	-	13.08	-	5
D2	.020	.053	0.51	1.35	
E	.602	.625	15.29	15.87	4
E1	.530	-	13.46	-	
E2	.178	.216	4.52	5.49	
e	.215	BSC	5.46	BSC]
Øk	.0	10	0.	25	
L	.559	.634	14.20	16.10	
L1	.146	.169	3.71	4.29	
ø₽	.140	.144	3.56	3.66]
øP1	-	.291	-	7.39	
Q	.209	.224	5.31	5.69	
S	.217	BSC	5.51	BSC	

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE

2. – DRAIN 3. – SOURCE

IGBTs, CoPACK

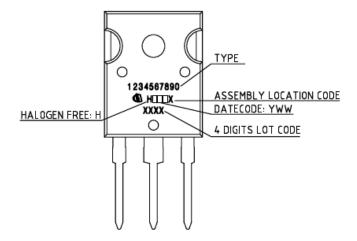
1.- GATE
2.- COLLECTOR
3.- EMITTER
4.- COLLECTOR

DIODES

1.- ANODE/OPEN 2.- CATHODE

3.- ANODE

TO-247AC Part Marking Information



TO-247AC package is not recommended for Surface Mount Application.



Revision History

Date	Rev.	Comments
2013-09-06	2.0	Final data sheet
2024-12-05	2.1	 Update datasheet to Infineon format Updated Part marking –page 8 Added disclaimer on last page.



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IRFP4137PbF



Revision history

IRFP4137PbF

Revision 2025-01-13, Rev. 1.0

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Ρ	rev	เดเเร	revi	sions

Revision Date Subjects (major changes since last revision)		Subjects (major changes since last revision)
1.0	2025-01-13	Update datasheet to Infineon format, Updated Part marking –page 8

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